

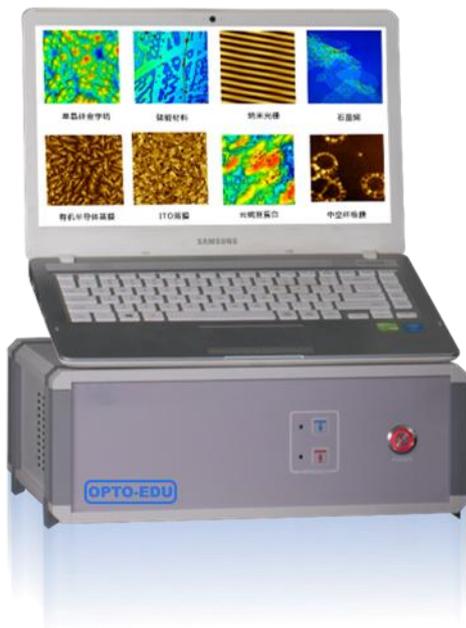


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A62.4505

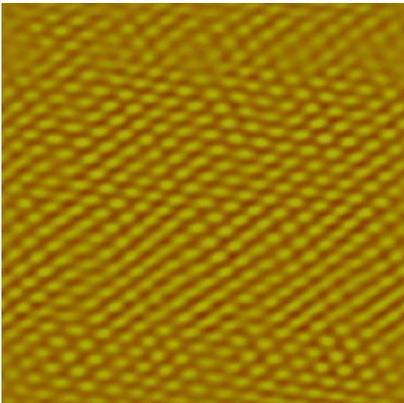
Optical + Atomic Force Microscope All-in-One AFM



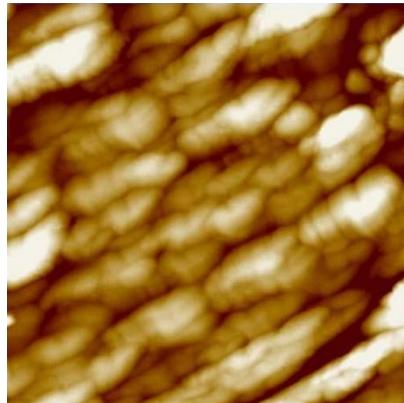
Product Details

- ◆ Integrated design of optical metallographic microscope and atomic force microscope, powerful functions
- ◆ It has both optical microscope and atomic force microscope imaging functions, both of which can work at the same time without affecting each other
- ◆ At the same time, it has the functions of optical 2D measurement and atomic force microscope 3D measurement
- ◆ The laser detection head and the sample scanning stage are integrated, the structure is very stable, and the anti-interference is strong
- ◆ Precision probe positioning device, laser spot alignment adjustment is very easy
- ◆ The single-axis drive sample automatically approaches the probe vertically, so that the needle tip is perpendicular to the sample scan
- ◆ The intelligent needle feeding method of motor-controlled pressurized piezoelectric ceramic automatic detection protects the probe and the sample
- ◆ Ultra-high magnification optical positioning system to achieve precise positioning of probe and sample scanning area
- ◆ Integrated scanner nonlinear correction user editor, nanometer

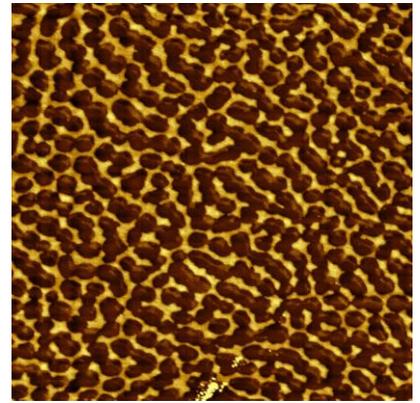
Application Case



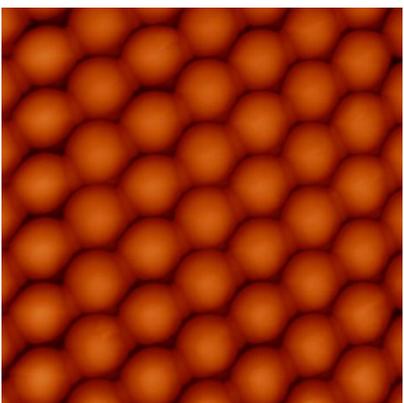
High-order graphite/scanning range $5\text{nm} \times 5\text{nm}$



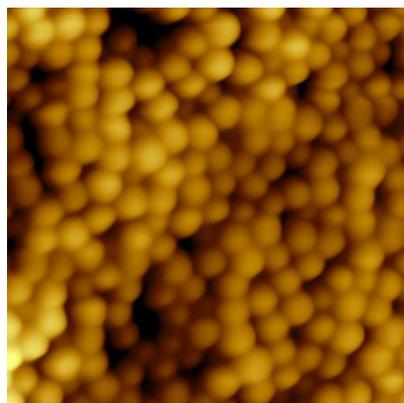
Gold clusters/scanning range $0.5\mu\text{m} \times 0.5\mu\text{m}$



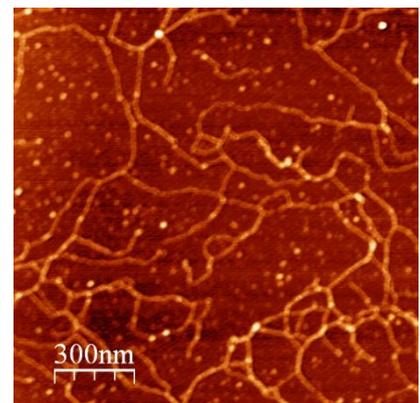
Polysaccharide $10\mu\text{m} \times 10\mu\text{m}$



Polystyrene ball $10\mu\text{m} \times 10\mu\text{m}$

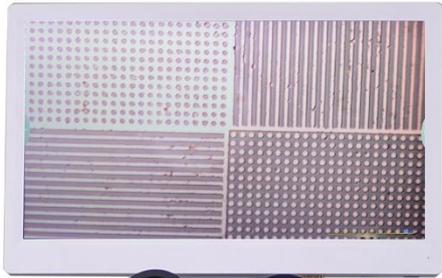


Polystyrene ball $5\mu\text{m} \times 5\mu\text{m}$

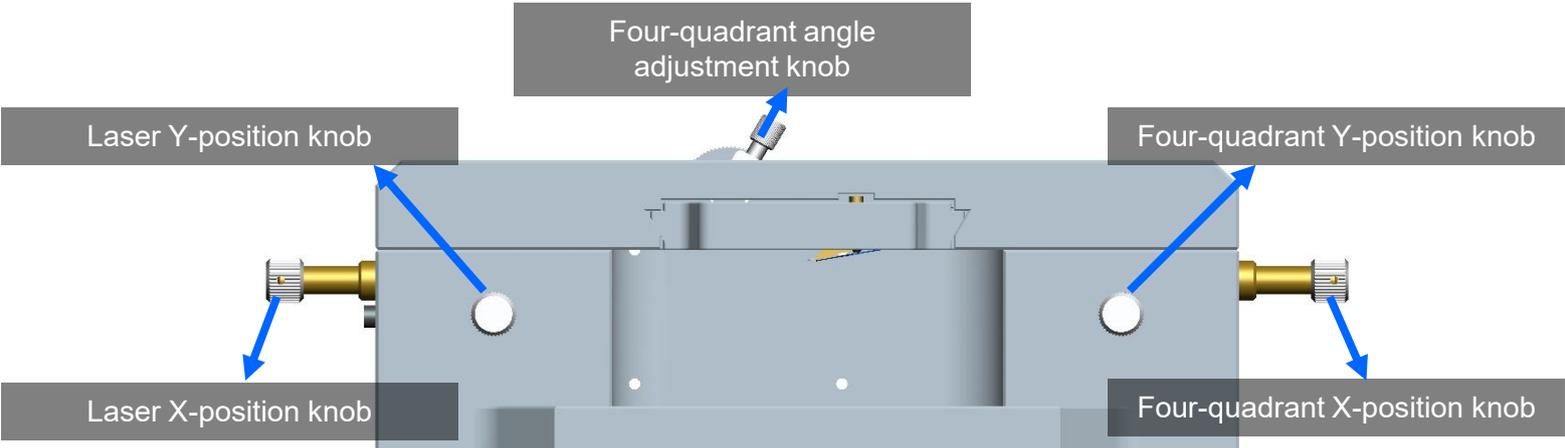


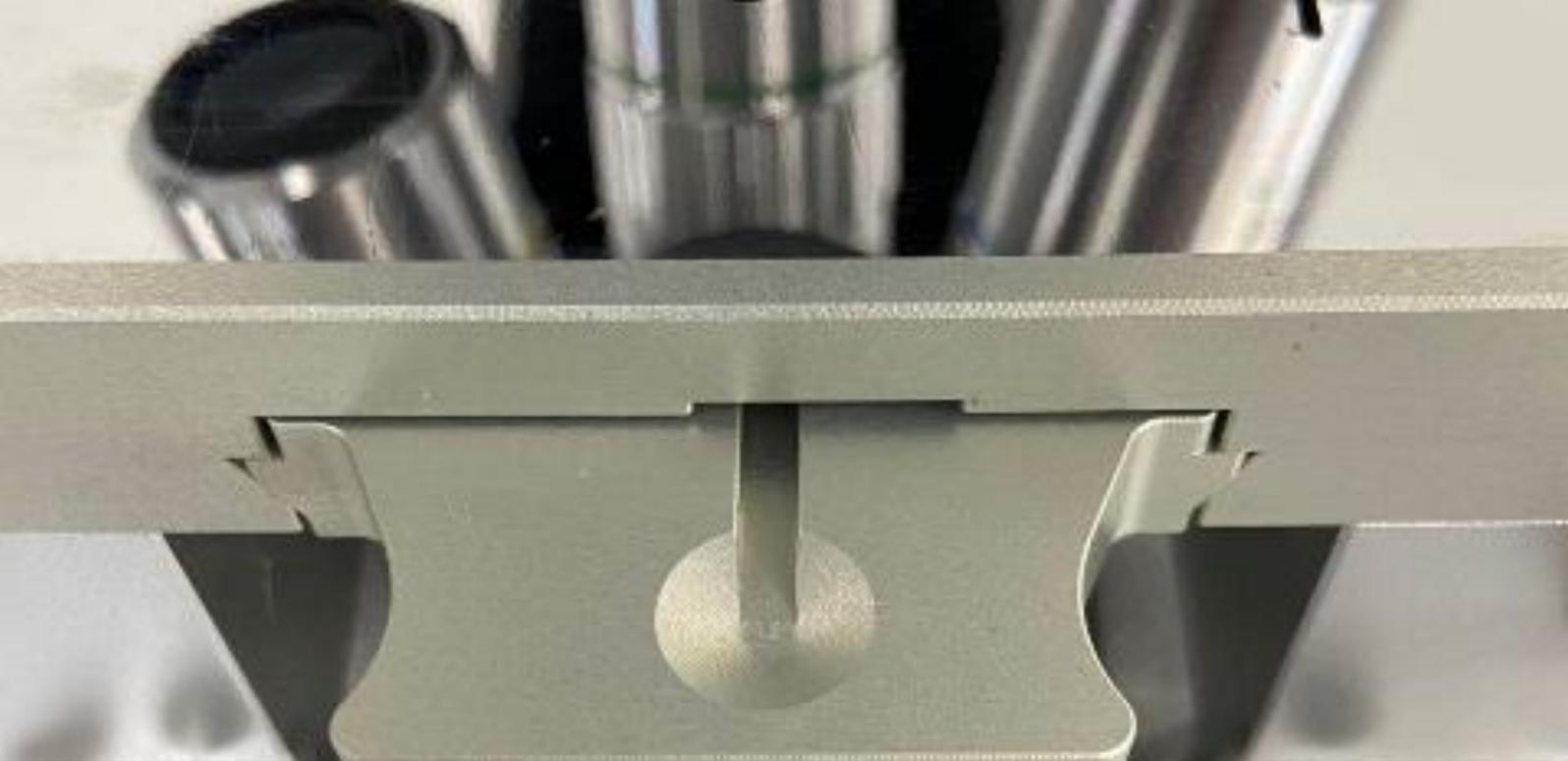
Polysaccharide $1.5\mu\text{m} \times 1.5\mu\text{m}$

Product Details



A62.4505 All-in-One AFM Optical + Atomic Force Microscope





Operation Note

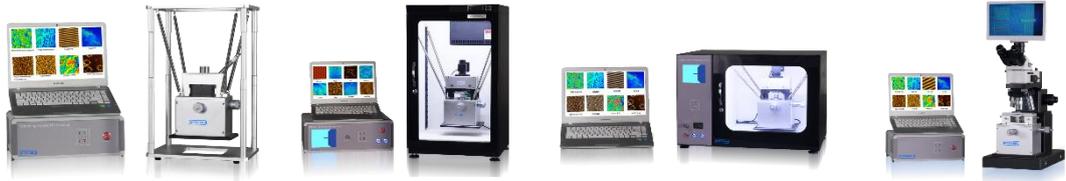
Use a syringe to inject the liquid required for the test into the sample liquid cell through the liquid tank of the probe holder, observe while injecting, and stop injecting the liquid until the liquid completely covers the probe and the glass.



Optical Components

Include filter, diopter adjustment, field diaphragm, aperture diaphragm, light source brightness adjustment, filter slot, Focusing knob.

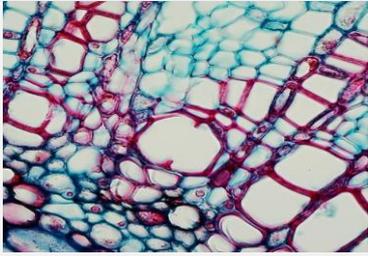
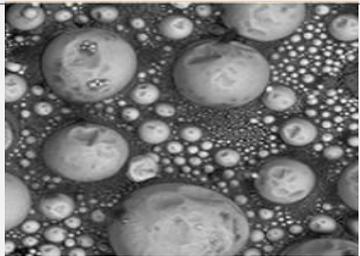
Specification



Specification	A62.4500	A62.4501	A62.4503	A62.4505
Work Mode	Tapping Mode 【Optional】 Contact Mode Friction Mode Phase Mode Magnetic Mode Electrostatic Mode	Contact Mode Tapping Mode 【Optional】 Friction Mode Phase Mode Magnetic Mode Electrostatic Mode	Contact Mode Tapping Mode 【Optional】 Friction Mode Phase Mode Magnetic Mode Electrostatic Mode	Contact Mode Tapping Mode 【Optional】 Friction Mode Phase Mode Magnetic Mode Electrostatic Mode
Current Spectrum Curve	RMS-Z Curve 【Optional】 F-Z Force Curve	RMS-Z Curve F-Z Force Curve	RMS-Z Curve F-Z Force Curve	RMS-Z Curve F-Z Force Curve
XY Scan Range	20×20um	20×20um	50×50um	50×50um
XY Scan Resolution	0.2nm	0.2nm	0.2nm	0.2nm
Z Scan Range	2.5um	2.5um	5um	5um
Y Scan Resolution	0.05nm	0.05nm	0.05nm	0.05nm
Scan Speed	0.6Hz~30Hz	0.6Hz~30Hz	0.6Hz~30Hz	0.6Hz~30Hz
Scan Angle	0~360°	0~360°	0~360°	0~360°
Sample Size	Φ≤90mm H≤20mm	Φ≤90mm H≤20mm	Φ≤90mm H≤20mm	Φ≤90mm H≤20mm
XY Stage Moving	15×15mm	15×15mm	25×25um	25×25um
Shock-Absorbing Design	Spring Suspension	Spring Suspension Metal Shielding Box	Spring Suspension Metal Shielding Box	-
Optical System	4x Objective Resolution 2.5um	4x Objective Resolution 2.5um	4x Objective Resolution 2.5um	Eyepiece 10x Infinity Plan LWD APO 5x10x20x50x 5.0M Digital Camera 10" LCD Monitor, With Measuring LED Kohler Illumination Coaxial Coarse & Fine Focusing
Output	USB2.0/3.0	USB2.0/3.0	USB2.0/3.0	USB2.0/3.0
Software	Win XP/7/8/10	Win XP/7/8/10	Win XP/7/8/10	Win XP/7/8/10

Specification

Scanning Probe Microscope (SPM) Compared to Other Microscopies

	Optical Microscope	Electron Microscope	Scanning Probe Microscope
Max Resolution	0.18um	0.00011um	0.00008um
Remark	Oil immersion 1500x 	Imaging diamond carbon atoms 	Imaging high-order graphitic carbon atoms 

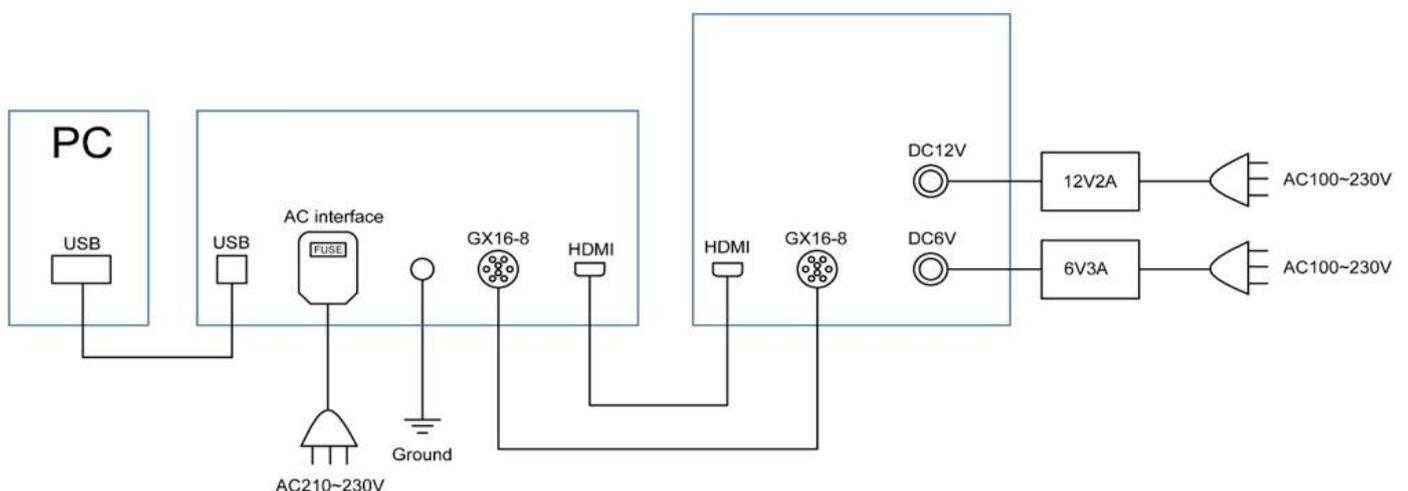
Depth of Field, Sample Preparation of Different Microscopes

	Resolution	Working Condition	Working Temperature	Damge to Sample	Inspection Depth
SPM	Atom Level 0.1nm	Normal, Liquid, Vacuum	Room or Low Temperature	None	1~2 Atom Level
TEM	Point 0.3~0.5nm Lattice 0.1~0.2nm	High Vaccum	Room Temperature	Small	Usually <100nm
SEM	6-10nm	High Vaccum	Room Temperature	Small	10mm @10x 1um @10000x
FIM	Atom Level 0.1nm	Super High Vaccum	30~80K	Damge	Atom Thickness

Force & Working Mode of Atomic Force Microscope (AFM)

Probe-Sample Interaction	Measure Signal	Information
Force	Electrostatic Force	Shape
Tunnel Current	Current	Shape, Conductivity
Magnetic Force	Phase	Magnetic Structure
Electrostatic Force	Phase	charge distribution

System Diaphragm



MICROSCOPE IS OUR FOCUS

Supply The Key To Micro World

Opto-Edu is one of the most professional supplier for microscope & educational instruments from China. We have been focusing in this field for more than 15 years, has a professional sales team who can assist our customer to find the BEST SELECTED microscope with competitive price and 3 YEARS Warranty.

25+ Year professional experience we know Microscopes the best!
150+ Microscope & accessory manufacturers supply all models from China
200+ Hot sale microscopes & Newest Models Updated Every Month
750+ Customer from all over the world & keep rising every day
1500+ Microscope products create your one-stop purchase platform
3000+ Educational Instruments For School, College And University Teaching
The Most Professional Microscope Manufacturer in China!

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